

**Notice of References Cited**

Application/Control No.

10/567,460

Applicant(s)/Patent Under  
Reexamination  
AOKI ET AL.

Examiner

Sunray R. Chang

Art Unit

2121

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,182,163	01-2001	Yamashita et al.	710/12
*	B	US-5,822,615	10-1998	Yamashita et al.	710/10
	C	US-			
	D	US-			
	E	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	S					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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